

<b>Notice of References Cited</b>		Application/Control No.	Applicant(s)/Patent Under Reexamination	
		10/551,553	TANAKA, TOSHIHIKO	
		Examiner	Art Unit	Page 1 of 1
		Jonathan Jelsma	1795	

#### U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,492,078 B1	12-2002	Ohnuma, Hidetoshi	430/30
*	B	US-2002/0136967 A1	09-2002	Sasaki et al.	430/5
*	C	US-6,685,848 B1	02-2004	Sasaki et al.	216/75
*	D	US-5,242,770	09-1993	Chen et al.	430/5
*	E	US-4,864,123	09-1989	Mizutani et al.	250/225
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

#### FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

#### NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

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